

PH3230S

N-channel TrenchMOS™ logic level FET

Rev. 02 — 23 April 2003

Product data

1. Product profile

1.1 Description

N-channel enhancement mode field-effect power transistor in a plastic package.

Product availability:

PH3230S in SOT669 (LFPAK).

1.2 Features

- Logic level compatible
- High density mounting
- Low drive current
- Very low on-state resistance.

1.3 Applications

- DC-to-DC converter
- Notebook computers
- Switched mode power supplies
- Computer motherboards.

1.4 Quick reference data

- $V_{DS} \leq 30 \text{ V}$
- $P_{tot} \leq 62.5 \text{ W}$
- $I_D \leq 107 \text{ A}$
- $R_{DS(on)} \leq 3.2 \text{ m}\Omega$.

2. Pinning information

Table 1: Pinning - SOT669 (LFPAK), simplified outline and symbol

Pin	Description	Simplified outline	Symbol
1,2,3	source (s)		
4	gate (g)		
mb	drain (d)		

SOT669 (LFPAK)

3. Limiting values

Table 2: Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

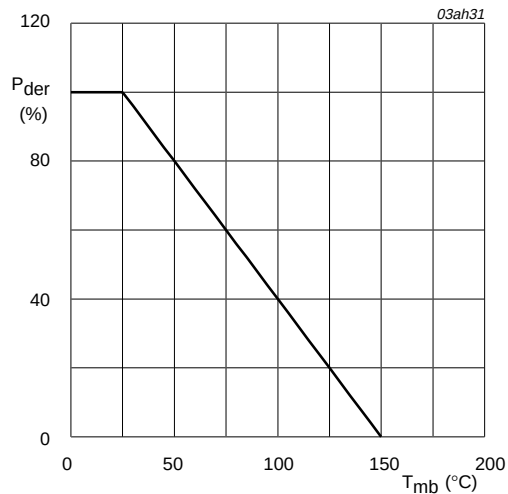
Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage (DC)	$T_j = 25$ to 150 °C	-	30	V
V_{GS}	gate-source voltage (DC)		-	± 20	V
I_D	drain current (DC)	$V_{GS} = 10$ V; $T_{mb} = 25$ °C; Figure 2 and 3	-	107	A
I_{DM}	peak drain current	$T_{mb} = 25$ °C; pulsed; $t_p \leq 10$ μ s; Figure 3	-	428	A
P_{tot}	total power dissipation	$T_{mb} = 25$ °C; Figure 1	-	62.5	W
T_{stg}	storage temperature		-55	+150	°C
T_j	junction temperature		-55	+150	°C

Source-drain diode

I_{SM}	peak source (diode forward) current	$T_{mb} = 25$ °C; pulsed; $t_p \leq 10$ μ s	-	107	A
----------	-------------------------------------	---	---	-----	---

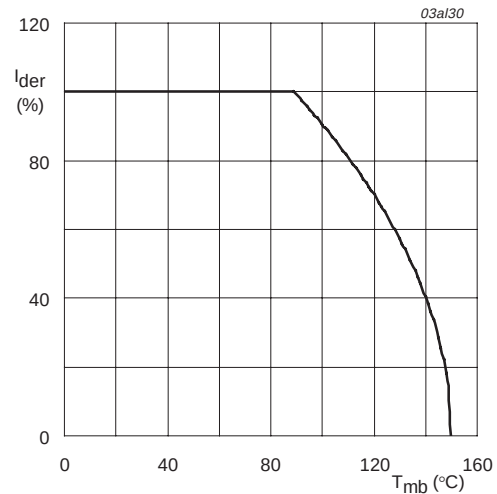
Avalanche ruggedness

$I_{DS(AL)R}$	repetitive drain-source avalanche current	$T_j = 25$ °C	-	5	A
$E_{DS(AL)R}$	repetitive drain-source avalanche energy	$T_j = 25$ °C; $R_{GS} \geq 50$ Ω ; $I_{DS(AL)R} = 5$ A; $V_{DD} = 15$ V; duty < 0.1%	-	2.5	mJ
$E_{DS(AL)S}$	non-repetitive drain-source avalanche energy	unclamped inductive load; $I_D = 50$ A; $V_{DD} \leq 15$ V; $R_{GS} = 50$ Ω ; $V_{GS} = 10$ V; starting $T_j = 25$ °C	-	250	mJ



$$P_{der} = \frac{P_{tot}}{P_{tot(25^\circ C)}} \times 100\%$$

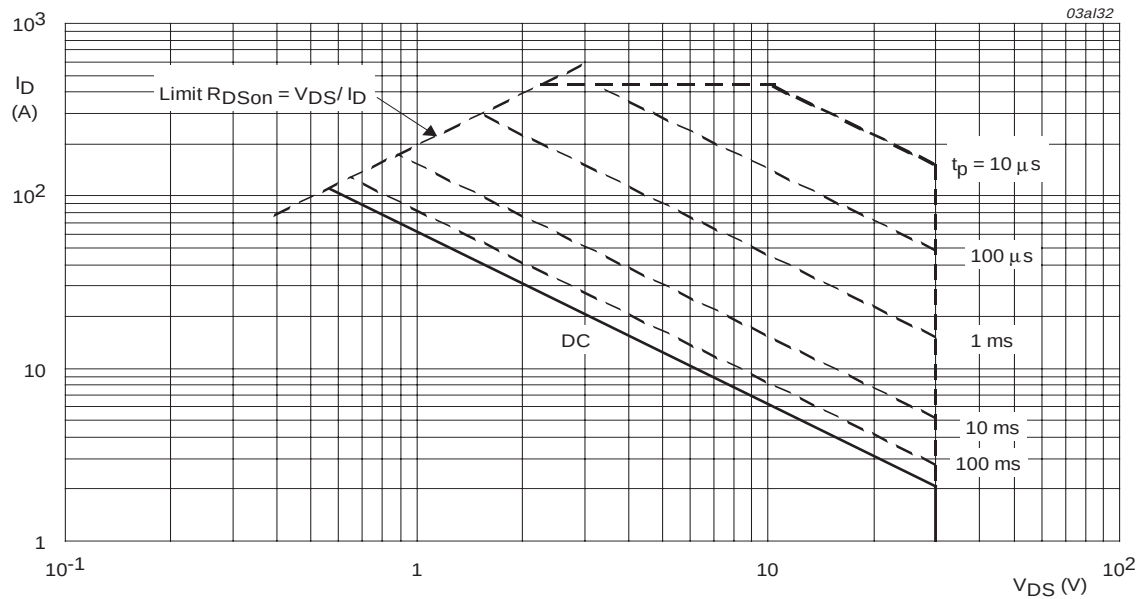
Fig 1. Normalized total power dissipation as a function of mounting base temperature.



$$V_{GS} \geq 10 \text{ V}$$

$$I_{der} = \frac{I_D}{I_{D(25^\circ C)}} \times 100\%$$

Fig 2. Normalized continuous drain current as a function of mounting base temperature.



$T_{mb} = 25\text{ }^{\circ}\text{C}$; I_{DM} is single pulse.

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage.

4. Thermal characteristics

Table 3: Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	Figure 4	-	-	2	K/W

4.1 Transient thermal impedance

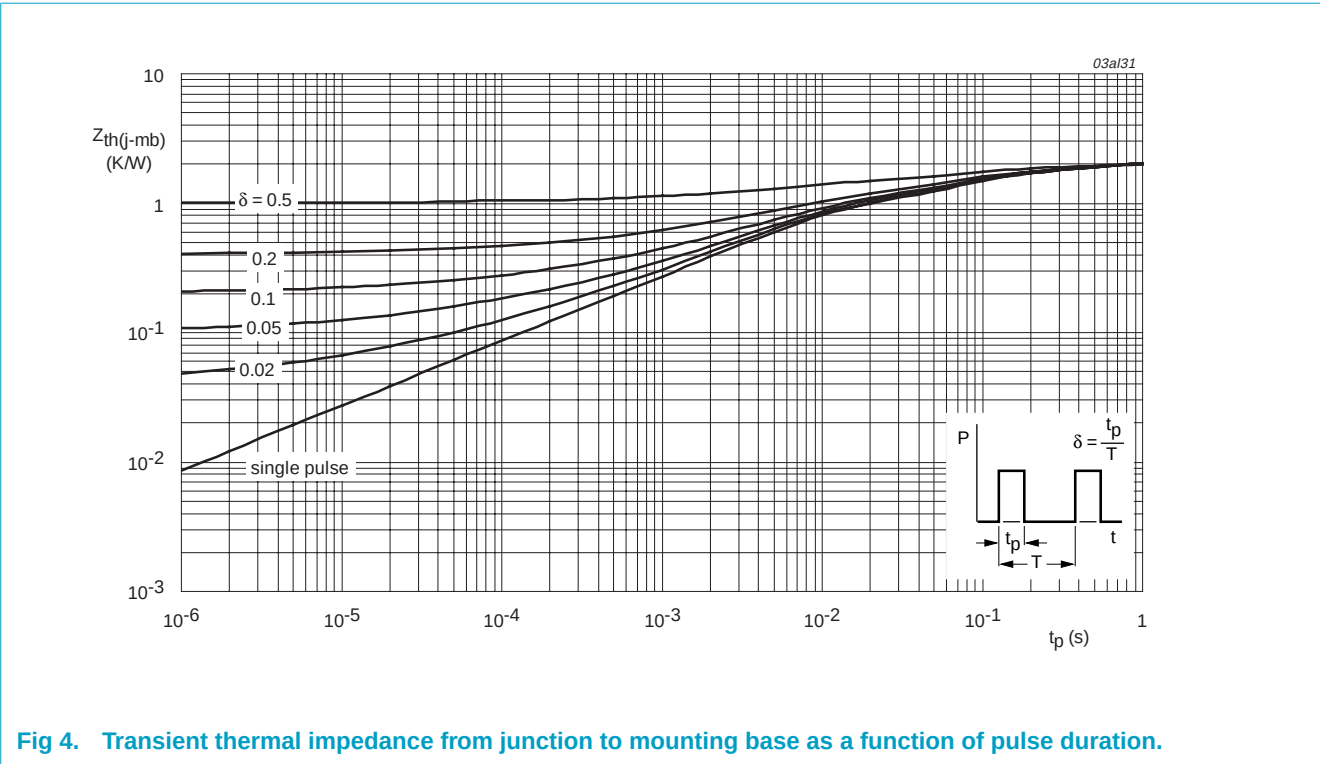


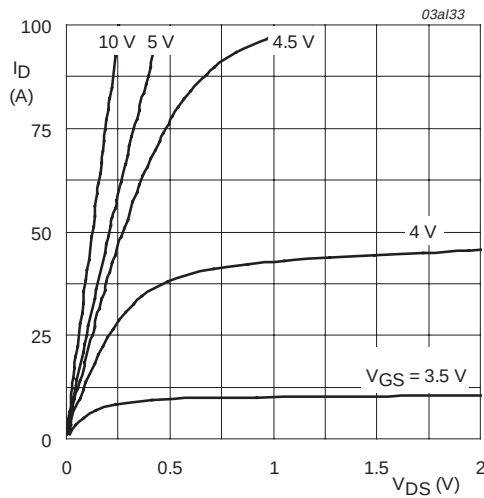
Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration.

5. Characteristics

Table 4: Characteristics

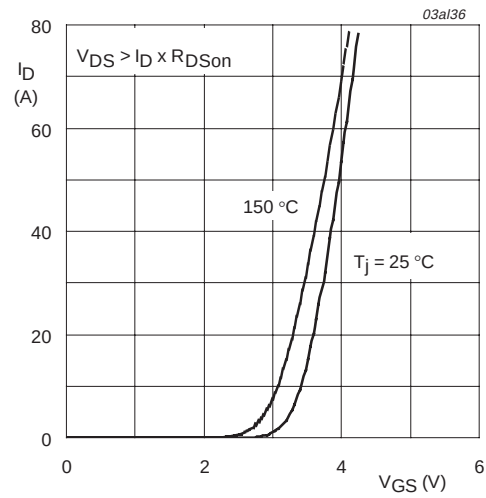
$T_j = 25\text{ }^{\circ}\text{C}$ unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
V _{(BR)DSS}	drain-source breakdown voltage	I _D = 10 mA; V _{GS} = 0 V	30	-	-	V
V _{GS(th)}	gate-source threshold voltage	I _D = 1 mA; V _{DS} = V _{GS} ; Figure 9	1	2	3	V
I _{DSS}	drain-source leakage current	V _{DS} = 30 V; V _{GS} = 0 V	-	-	1	μA
I _{GSS}	gate-source leakage current	V _{GS} = ±20 V; V _{DS} = 0 V	-	10	100	nA
R _{DSon}	drain-source on-state resistance	V _{GS} = 10 V; I _D = 25 A; Figure 7 and 8	-	2.7	3.2	mΩ
		V _{GS} = 4.5 V; I _D = 25 A; Figure 8	-	5.0	6.5	mΩ
Dynamic characteristics						
g _{fs}	forward transconductance	V _{DS} = 10 V; I _D = 25 A; Figure 11	39	55	-	S
Q _{g(tot)}	total gate charge	I _D = 50 A; V _{DD} = 10 V; V _{GS} = 5 V; Figure 14	-	42	-	nC
Q _{gs}	gate-source charge		-	21	-	nC
Q _{gd}	gate-drain (Miller) charge		-	13	-	nC
C _{iss}	input capacitance	V _{GS} = 0 V; V _{DS} = 10 V; f = 1 MHz; Figure 12	-	4100	-	pF
C _{oss}	output capacitance		-	1150	-	pF
C _{rss}	reverse transfer capacitance		-	750	-	pF
t _{d(on)}	turn-on delay time	V _{DD} = 10 V; I _D = 25 A; V _{GS} = 10 V; R _G = 4.7 Ω	-	14	-	ns
t _r	rise time		-	145	-	ns
t _{d(off)}	turn-off delay time		-	85	-	ns
t _f	fall time		-	50	-	ns
Source-drain (reverse) diode						
V _{SD}	source-drain (diode forward) voltage	I _S = 50 A; V _{GS} = 0 V; Figure 13	-	0.85	1.2	V
t _{rr}	reverse recovery time	I _S = 50 A; dI _S /dt = −50 A/μs; V _{GS} = 0 V	-	46	-	ns



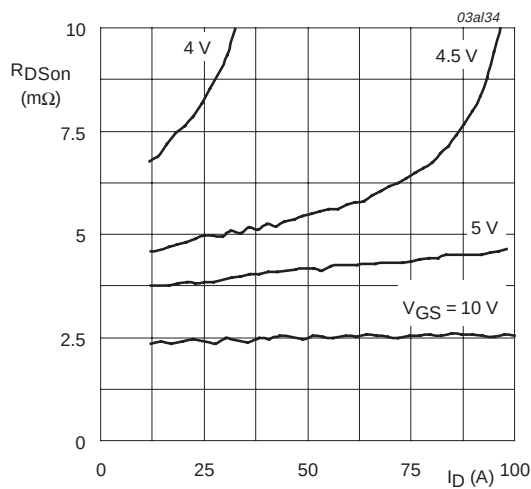
$T_j = 25^\circ\text{C}$

Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values.



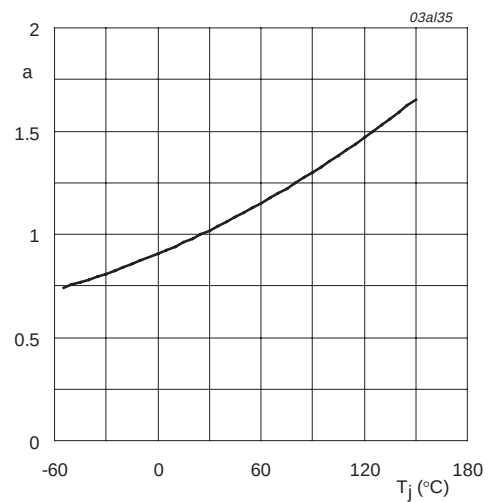
$T_j = 25^\circ\text{C}$ and 150°C ; $V_{DS} > I_D \times R_{DSon}$

Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values.



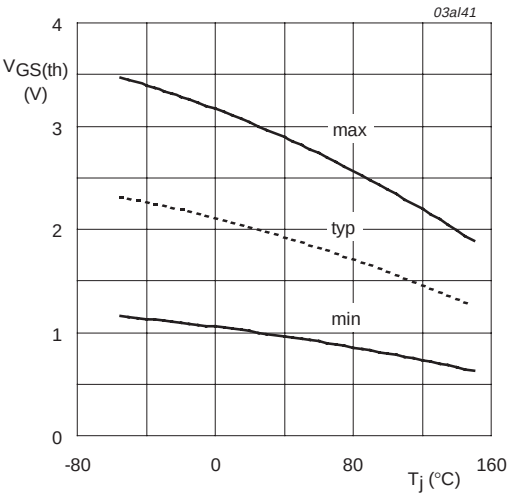
$T_j = 25^\circ\text{C}$

Fig 7. Drain-source on-state resistance as a function of drain current; typical values.



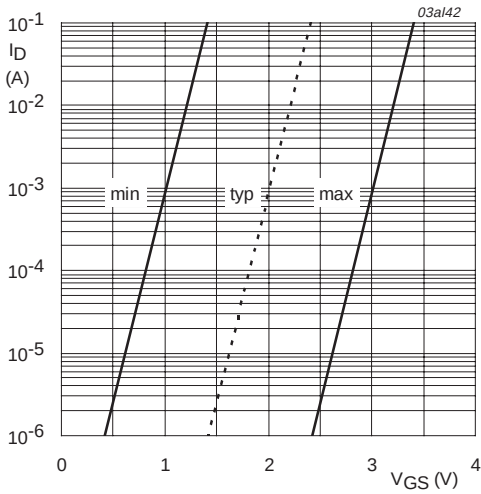
$$a = \frac{R_{DSon}}{R_{DSon(25^\circ\text{C})}}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature.



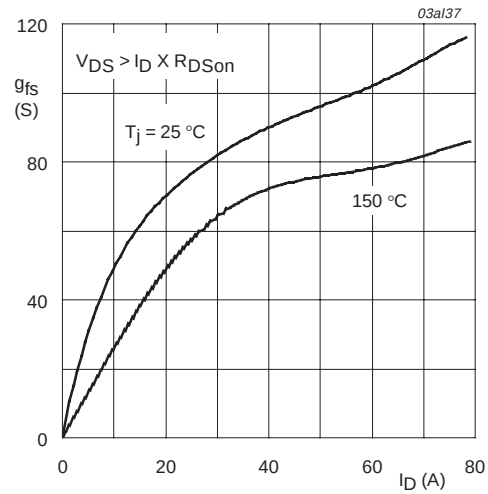
$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$

Fig 9. Gate-source threshold voltage as a function of junction temperature



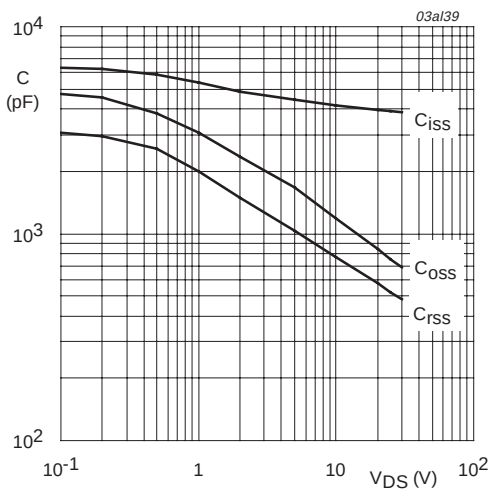
$T_J = 25 \text{ }^\circ\text{C}$

Fig 10. Sub-threshold drain current as a function of gate-source voltage.



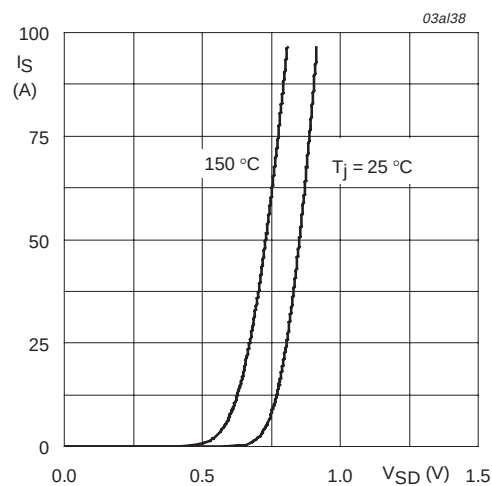
$T_J = 25 \text{ }^\circ\text{C}$ and $150 \text{ }^\circ\text{C}$; $V_{DS} > I_D \times R_{DSon}$

Fig 11. Forward transconductance as a function of drain current; typical values.



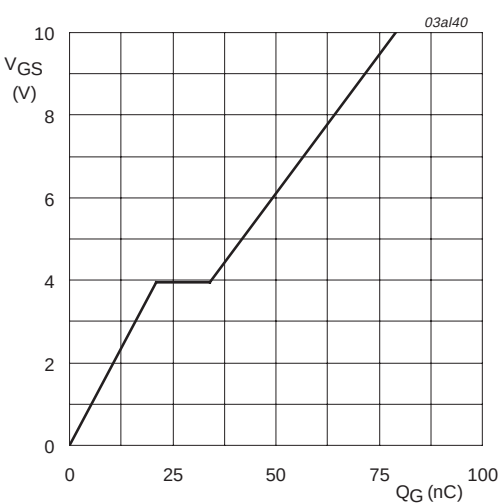
$V_{GS} = 0 \text{ V}$; $f = 1 \text{ MHz}$

Fig 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values.



T_J = 25 °C and 150 °C; V_{GS} = 0 V

Fig 13. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values.



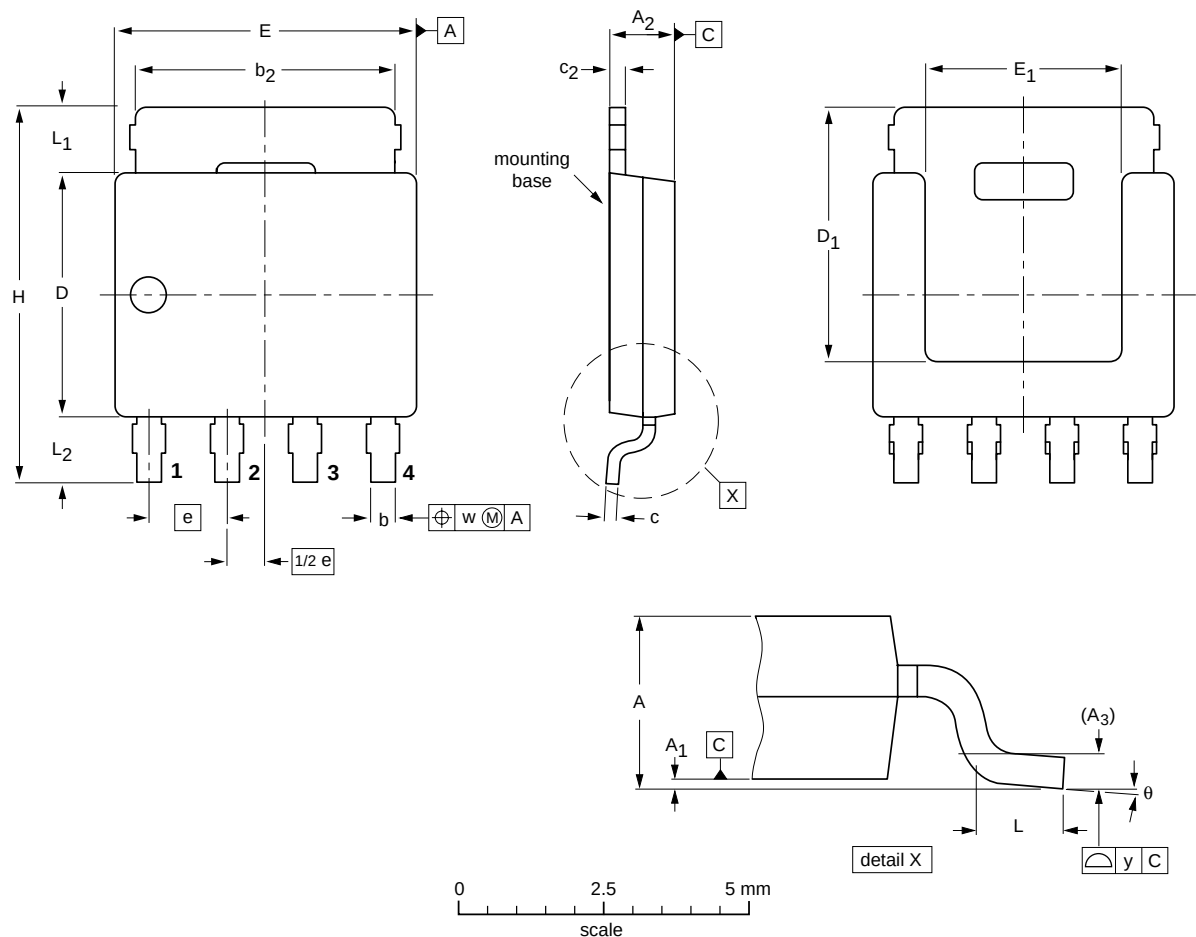
T_J = 25 °C; I_D = 50 A; V_{DD} = 10 V

Fig 14. Gate-source voltage as a function of gate charge; typical values.

6. Package outline

Plastic single-ended surface mounted package (Philips version LPAK); 4 leads

SOT669



DIMENSIONS (mm are the original dimensions)

UNIT	A	A ₁	A ₂	A ₃	b	b ₂	c	c ₂	D ⁽¹⁾	D ₁ ⁽¹⁾ max	E ⁽¹⁾	E ₁ ⁽¹⁾	e	H	L	L ₁	L ₂	w	y	θ
mm	1.20 1.01	0.15 0.00	1.10 0.95	0.25	0.50 0.35	4.41 3.62	0.25 0.19	0.30 0.24	4.10 3.80	4.20	5.0 4.8	3.3 3.1	1.27	6.2 5.8	0.85 0.40	1.3 0.8	1.3 0.8	0.25	0.1	8° 0°

Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT669		MO-235				02-07-10 03-02-05

Fig 15. SOT669 (LPAK).

7. Revision history

Table 5: Revision history

Rev	Date	CPCN	Description
02	20030423	-	Product data (9397 750 11279) Modifications: • Avalanche ruggedness data added in Table 2 • Correction to Figure 6 • Correction to Figure 11 • Correction to Figure 13
01	20030212	-	Preliminary data (9397 750 11078)

8. Data sheet status

Level	Data sheet status ^[1]	Product status ^{[2][3]}	Definition
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
II	Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product.
III	Product data	Production	This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Relevant changes will be communicated via a Customer Product/Process Change Notification (CPCN).

[1] Please consult the most recently issued data sheet before initiating or completing a design.

[2] The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL <http://www.semiconductors.philips.com>.

[3] For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

9. Definitions

Short-form specification — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

Application information — Applications that are described herein for any of these products are for illustrative purposes only. Philips Semiconductors make no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips Semiconductors for any damages resulting from such application.

Right to make changes — Philips Semiconductors reserves the right to make changes in the products - including circuits, standard cells, and/or software - described or contained herein in order to improve design and/or performance. When the product is in full production (status 'Production'), relevant changes will be communicated via a Customer Product/Process Change Notification (CPCN). Philips Semiconductors assumes no responsibility or liability for the use of any of these products, conveys no licence or title under any patent, copyright, or mask work right to these products, and makes no representations or warranties that these products are free from patent, copyright, or mask work right infringement, unless otherwise specified.

11. Trademarks

TrenchMOS — is a trademark of Koninklijke Philips Electronics N.V.

10. Disclaimers

Life support — These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips Semiconductors

Contact information

For additional information, please visit <http://www.semiconductors.philips.com>.

For sales office addresses, send e-mail to: sales.addresses@www.semiconductors.philips.com.

Fax: +31 40 27 24825

Contents

1 **Product profile** 1

1.1 Description 1

1.2 Features 1

1.3 Applications 1

1.4 Quick reference data. 1

2 **Pinning information**. 1

3 **Limiting values**. 2

4 **Thermal characteristics**. 4

4.1 Transient thermal impedance 4

5 **Characteristics**. 5

6 **Package outline** 9

7 **Revision history**. 10

8 **Data sheet status** 11

9 **Definitions** 11

10 **Disclaimers**. 11

11 **Trademarks**. 11

